## WHAT IS CLAIMED IS:

- 1 1. A method for manufacturing optoelectronic devices, comprising the steps of:
- 2 forming a layered structure having a plurality of layers including a bottom electrode layer,
- a top electrode layer, and one or more active layers between the top and bottom electrode
- 4 layers;
- 5 cutting through one or more of the layers of the layered structure to divide the layered
- 6 structure into one or more separate device sections, each section having a portion of the
- 7 active layer disposed between portions of the top and bottom electrode layers, wherein at
- 8 least one of the layers is an unpatterned layer at the time of cutting;
- 9 providing at least one form of protection that prevents shorts which could arise from the
- 10 cutting steps;
- assembling two or more device sections into a module; and
- electrically connecting the bottom electrode layer portion of one device section to the top
- electrode layer portion of another device section.
- 1 2. The method of claim 1 wherein cutting through one or more of the layers of the layered
- 2 structure includes cutting through a substrate layer of the layered structure
- 1 3. The method of claim 1 wherein cutting through one or more of the layers of the layered
- 2 structure includes cutting through all of the layers of the layered structure.
- 1 4. The method of claim 1 wherein all of the layers of the layered structure are unpatterned
- 2 layers at the time of cutting.
- 1 5. The method of claim 1, further comprising protecting an edge of a device section against
- 2 undesired electrical contact between two or more of the bottom electrode, top electrode
- 3 and active layer portions.
- 1 6. The method of claim 5 wherein protecting an edge of a device section includes the step
- of, before cutting through one or more of the layers of the layered structure, placing short-
- 3 proofing material between adjacent layers of the layered structure proximate a location
- 4 where the layered structure is to be cut.
- 1 7. The method of claim 5, wherein protecting an edge of a device section includes the step
- 2 of passivating a side of the device section.

- 1 8. The method of claim 7 wherein passivating a side of the device section includes the step
- of oxidizing the side, exposing the side to passivating chemicals, or coating the side with
- 3 a passivating substance.
- 1 9. The method of claim 1 wherein assembling two or more device sections into a module
- 2 includes the step of laminating the two or more device sections side-by-side between
- 3 layers of laminating material.
- 1 10. The method of claim 1, further comprising the step of, before cutting through one or more
- of the layers of the layered structure to divide the layered structure into one or more
- device sections, patterning the top electrode layer and/or active layers to define the one or
- 4 more device module sections.
- 1 11. The method of claim 10, further comprising protecting an edge of a device section against
- 2 undesired electrical contact between two or more of the bottom electrode, top electrode
- and active layer portions of the one or more device module sections.
- 1 12. The method of claim 11, wherein protecting an edge of a device section includes the steps
- 2 of:
- 3 after patterning the top electrode layer and/or active layers, disposing an insulating
- 4 material between the active layer portions of two or more adjacent device sections.
- 1 13. The method of claim 12 wherein forming a layered structure includes covering the active
- 2 layer and the insulating material with an unpatterned top electrode layer before cutting the
- 3 layered structure to divide the layered structure into one or more device sections.
- 1 14. The method of claim 12 wherein cutting the layered structure includes cutting the layered
- 2 structure at locations corresponding to the insulating material.
- 1 15. The method of claim 1 wherein electrically connecting the bottom electrode layer portion
- 2 of one device section to the top electrode layer portion of another device section includes
- 3 the steps of:
- 4 exposing a portion of an upper surface of the bottom electrode layer portion of a first
- device section; and connecting an electrically conductive material between the top
- 6 electrode layer portion of a second device section and the exposed portion of the upper
- 7 surface of the bottom electrode layer.

- 1 16. The method of claim 1 wherein the optoelectronic device is a photovoltaic cell.
- 1 17. The method of claim 1 wherein the optoelectronic device is an organic light emitting
- device (OLED).